

February 2007

# FDMB668P

# P-Channel 1.8V Logic Level PowerTrench® MOSFET -20V, -6.1A, $35m\Omega$

#### **Features**

- Max  $r_{DS(on)} = 35m\Omega$  at  $V_{GS} = -4.5V$ ,  $I_D = -6.1A$
- Max  $r_{DS(on)}$  = 50m $\Omega$  at  $V_{GS}$  = -2.5V,  $I_D$  = -5.1A
- Max  $r_{DS(on)}$  = 70m $\Omega$  at  $V_{GS}$  = -1.8V,  $I_D$  = -4.3A
- Excellent for portable application at V<sub>GS</sub> = -1.8V
- Thin profile Maximum height = 0.8mm
- RoHS compliant

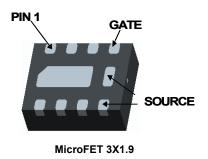


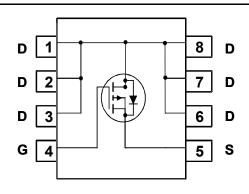
# **General Description**

FDMB668P is excellent for load switch and DC-DC conversion among portable electronics. It achieves an optimal balance among efficiency, thermal transfer and small form by integrating a P-channel MOSFET with minimized on-state resistance into a MicroFET 3x1.9 package. When optimizing the dimension of portable applications, this little device offers a very efficient solution.

# **Applications**

- Load Switch in:
  - -HDD
  - -Portable Gaming, MP3
  - -Notebook
- DC/DC Conversion





## **MOSFET Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage		-20	V
V <sub>GS</sub>	Gate to Source Voltage		±8	V
	Drain Current -Continuous	(Note 1a)	-6.1	^
ID	-Pulsed		-40	Α
D	Power Dissipation	(Note 1a)	1.9	10/
$P_{D}$	Power Dissipation	(Note 1b)	0.8	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	165	-C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
668	FDMB668P	MicroFET 3X1.9	7"	8mm	3000 units

# **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25°C		-11.4		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16V, V_{GS} = 0V$			-1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 8V, \ V_{DS} = 0V$			±100	nA

#### On Characteristics (Note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.4	-0.6	-1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, referenced to 25°C		2.8		mV/°C
	r <sub>DS(on)</sub> Static Drain to Source On Resistance	$V_{GS} = -4.5V, I_D = -6.1A$		22	35	
-		$V_{GS} = -2.5V, I_D = -5.1A$		27	50	mΩ
DS(on)		$V_{GS} = -1.8V, I_D = -4.3A$		35	70	1115.2
	$V_{GS} = -4.5V$ , $I_D = -6.1A$ , $T_J = 125$ °C		31	50		
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -4.5V$ , $I_{D} = -6.1A$		27		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V - 40V V - 0V	1565	2085	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1MHz	210	280	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1111112	175	265	pF

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	.,	$V_{DD}$ = -10V, $I_{D}$ = -6.1A $V_{GS}$ = -4.5V, $R_{GEN}$ = 6 $\Omega$		7	14	ns
t <sub>r</sub>	Rise Time	$V_{DD} = -10V, I_D = -6.$			9	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = -4.5V, K <sub>GEN</sub>			176	282	ns
t <sub>f</sub>	Fall Time				84	135	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0V to -10V			42	59	nC
Qg	Total Gate Charge	$V_{GS}$ = 0V to -5V	V <sub>DD</sub> = -10V		22	31	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		$I_{D} = -6.1A$		3		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge				5		nC

## **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V$ , $I_S = -1.6A$ (Note 2)	-0.7	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> = -6.1A. di/dt = 100A/μs	29	44	ns
Q <sub>rr</sub>	Reverse Recovery Charge	- 1F0.1A, α//αι - 100A/μs	15	23	nC

#### Notes:

<sup>1:</sup> R<sub>0JA</sub> is the sum of the junction-to-case and case-to- ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JC</sub> is guaranteed by design while R<sub>0JA</sub> is determined by the user's board design.



a) 65°C/W when mounted on a 1in² pad of 2 oz copper



**b)**  $165^{\circ}\text{C/W}$  when mounted on a minimum pad .

2: Pulse Test: Pulse Width  $\leq$  300 us, Duty Cycle  $\leq$  2%.

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

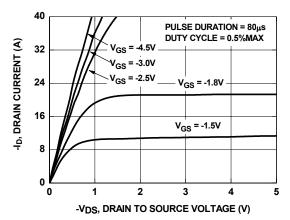
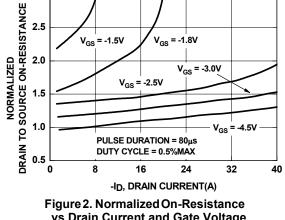


Figure 1. On-Region Characteristics



3.0

vs Drain Current and Gate Voltage

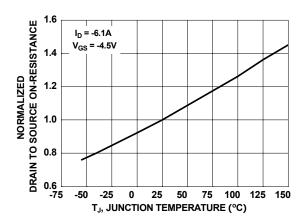


Figure 3. Normalized On-Resistance vs Junction Temperature

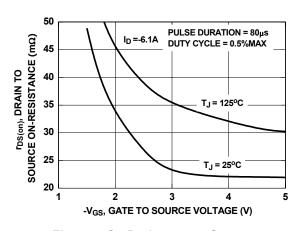


Figure 4. On-Resistance vs Gate to Source Voltage

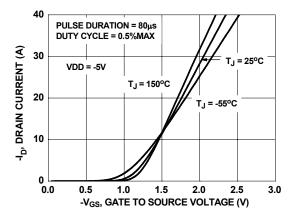


Figure 5. Transfer Characteristics

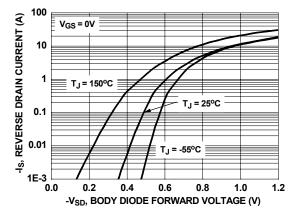


Figure 6. Source to Drain Diode **Forward Voltage vs Source Current** 

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# **Typical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

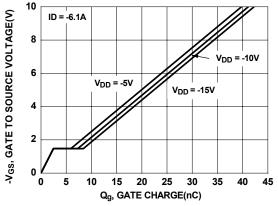


Figure 7. Gate Charge Characteristics

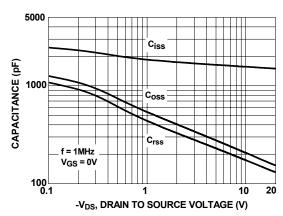


Figure 8. Capacitance vs Drain to Source Voltage

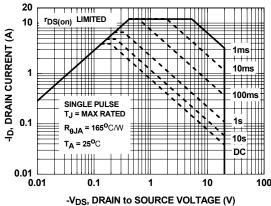


Figure 9. Forward Bias Safe

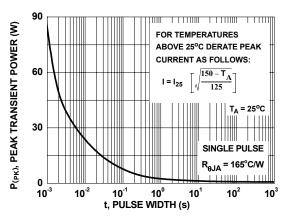
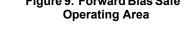


Figure 10. Single Pulse Maximum Power Dissipation



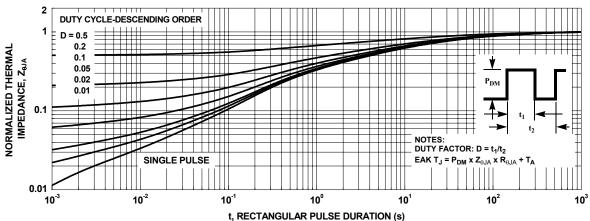
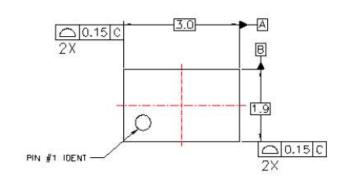
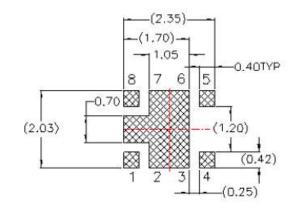


Figure 11. Transient Thermal Response Curve

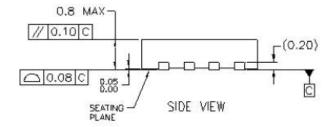
# **Dimensional Outline and Pad Layout**

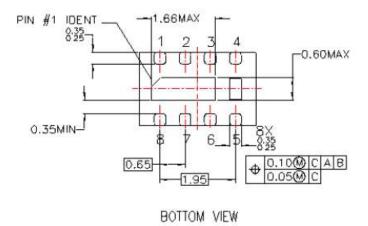




TOP VIEW

RECOMMENDED LAND PATTERN





MLP08IrevA

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